

<b>Notice of References Cited</b>	Application/Control No. 09/881,547	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner William J. Kimowicz	Art Unit 2652	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,493,310 B1	12-2002	Kim et al.	720/611
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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